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FDMS3620S PowerTrench[®] PowerStage 25V Asymmetric Dual N-Channel MOSFET

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 4.7 m Ω at V_{GS} = 10 V, I_D = 17.5 A
- Max $r_{DS(on)}$ = 5.5 m Ω at V_{GS} = 4.5 V, I_D = 16 A

Q2: N-Channel

- Max $r_{DS(on)}$ = 1.0 m Ω at V_{GS} = 10 V, I_D = 38 A
- Max r_{DS(on)} = 1.2 mΩ at V_{GS} = 4.5 V, I_D = 35 A
- Low inductance packaging shortens rise/fall times, resulting in lower switching losses
- MOSFET integration enables optimum layout for lower circuit inductance and reduced switch node ringing
- RoHS Compliant

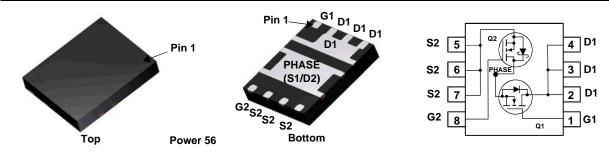


General Description

This device includes two specialized N-Channel MOSFETs in a dual PQFN package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET (Q2) have been designed to provide optimal power efficiency.

Applications

- Computing
- Communications
- General Purpose Point of Load
- Notebook VCORE



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | | Q1 | Q2 | Units |
|-----------------------------------|--|------------------------|--------------------|-------------------|-------|
| V _{DS} | Drain to Source Voltage | | 25 | 25 | V |
| V _{GS} | Gate to Source Voltage | (Note 4) | ±12 | ±12 | V |
| | Drain Current -Continuous (Package limited) | T _C = 25 °C | 30 | 49 | |
| 1 | -Continuous (Silicon limited) | T _C = 25 °C | 76 | 211 | Α |
| D | -Continuous | T _A = 25 °C | 17.5 ^{1a} | 38 ^{1b} | A |
| | -Pulsed | | 70 | 150 | |
| E _{AS} | Single Pulse Avalanche Energy | (Note 3) | 29 | 135 | mJ |
| D | Power Dissipation for Single Operation | T _A = 25 °C | 2.2 ^{1a} | 2.5 ^{1b} | w |
| PD | Power Dissipation for Single Operation | T _A = 25 °C | 1.0 ^{1c} | 1.0 ^{1d} | vv |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to | +150 | °C |

Thermal Characteristics

| R_{\thetaJA} | Thermal Resistance, Junction to Ambient | 57 ^{1a} | 50 ^{1b} | |
|---------------------|---|-------------------|-------------------|------|
| R_{\thetaJA} | Thermal Resistance, Junction to Ambient | 125 ^{1c} | 120 ^{1d} | °C/W |
| $R_{	ext{	heta}JC}$ | Thermal Resistance, Junction to Case | 3.0 | 1.7 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|-----------|----------|-----------|------------|------------|
| 08OD 06OD | FDMS3620S | Power 56 | 13 " | 12 mm | 3000 units |

July 2012

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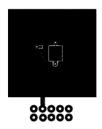
| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units |
|--|---|---|----------|------------|-------------------|-------------------|----------|
| Off Chara | octeristics | | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$ $I_D = 1 \ m A, \ V_{GS} = 0 \ V$ | Q1 Q2 | 25 25 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 10 \ m$ A, referenced to 25 °C | Q1 Q2 | | 12 16 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 20 V, V _{GS} = 0 V | Q1 Q2 | | | 1 500 | μΑ μΑ |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = 12/-8 V, V _{DS} = 0 V | Q1 Q2 | | | ±100 ±100 | nA nA |
| On Chara | cteristics | | | | | | |
| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$ $V_{GS} = V_{DS}$, $I_D = 1 \ m A$ | Q1 Q2 | 0.8 1.1 | 1.2 1.3 | 2.0 2.2 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 10 \ m$ A, referenced to 25 °C | Q1 Q2 | | -4 -4 | | mV/°C |
| [D Q() | Drain to Source On Resistance | $ \begin{array}{l} V_{GS} = 10 \text{ V}, \ I_D = 17.5 \text{ A} \\ V_{GS} = 4.5 \text{ V}, \ I_D = 16 \text{ A} \\ V_{GS} = 10 \text{ V}, \ I_D = 17.5 \text{ A}, T_J = 125 \ ^\circ\text{C} \end{array} $ | Q1 | | 3.8 4.4 5.4 | 4.7 5.5 7.0 | mΩ |
| r _{DS(on)} | Drain to Source On Resistance | $V_{GS} = 10 V, I_D = 38 A$ $V_{GS} = 4.5 V, I_D = 35 A$ $V_{GS} = 10 V, I_D = 38 A, T_J = 125 °C$ | Q2 | Q2 | 0.8 0.9 1.1 | 1.0 1.2 1.5 | 11122 |
| 9fs | Forward Transconductance | $V_{DS} = 5 V, I_D = 17.5 A$ $V_{DS} = 5 V, I_D = 38 A$ | Q1 Q2 | | 100 271 | | S |
| Dynamic | Characteristics | | | | | | |
| C _{iss} | Input Capacitance | Q1: V _{DS} = 13 V, V _{GS} = 0 V, f = 1 MHZ | Q1 Q2 | | 1570 6861 | | pF |
| C _{oss} | Output Capacitance | Q2: | Q1 Q2 | | 448 1828 | | pF |
| C _{rss} | Reverse Transfer Capacitance | V _{DS} = 13 V, V _{GS} = 0 V, f = 1 MHZ | Q1 Q2 | | 61 232 | | pF |
| R _g | Gate Resistance | | Q1 Q2 | 0.1 0.1 | 0.4 0.6 | 3.3 3.5 | Ω |
| Switching | g Characteristics | | | | | | |
| t _{d(on)} | Turn-On Delay Time | | Q1 Q2 | | 7 14 | | ns |
| t _r | Rise Time | Q1: V _{DD} = 13 V, I _D = 17.5 A, R _{GEN} = 6 Ω | Q1 Q2 | | 2 7 | | ns |

| t _{d(on)} | Turn-On Delay Time | | | Q2 | 7 14 | ns |
|---------------------|-------------------------------|--|--|----------|-------------|----|
| t _r | Rise Time | Q1: V _{DD} = 13 V, I _D = 17.5 | 5 A, R_{GEN} = 6 Ω | Q1 Q2 | 2 7 | ns |
| t _{d(off)} | Turn-Off Delay Time | Q2: V _{DD} = 13 V, I _D = 38 / | A $B_{OEN} = 6.0$ | Q1 Q2 | 23 41 | ns |
| t _f | Fall Time | | (, TGEN - 0 12 | Q1 Q2 | 2 5 | ns |
| Qg | Total Gate Charge | $V_{GS} = 0$ V to 10 V | | Q1 Q2 | 26 106 | nC |
| Qg | Total Gate Charge | $V_{GS} = 0$ V to 4.5 V | V _{DD} = 13 V, I _D = 17.5 A | Q1 Q2 | 12 50 | nC |
| Q _{gs} | Gate to Source Gate Charge | | Q2 V _{DD} = 13 V, | Q1 Q2 | 3.3 12.9 | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | $D_{\rm D} = 38 {\rm A}$ | Q1 Q2 | 2.7 12 | nC |

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Мах | Units |
|--------------------|---|---|------|-----|-----|-----|-------|
| Drain-So | urce Diode Characteristics | | | | | | |
| V | Source to Drein Diade Ferward Valtage | $V_{GS} = 0 V, I_S = 17.5 A$ (Note 2) | Q1 | | 0.8 | 1.2 | V |
| V _{SD} | D Source to Drain Diode Forward Voltage | $V_{GS} = 0 V, I_S = 38 A$ (Note 2) | Q2 | | 0.8 | 1.2 | V |
| | | Q1 | Q1 | | 23 | | |
| ۲r | Reverse Recovery Time | I _F = 17.5 A, di/dt = 100 A/μs | Q2 | | 38 | | ns |
| 2 | | Q2 | Q1 | | 9 | | - |
| Q _{rr} Re | Reverse Recovery Charge | I _F = 38 A, di/dt = 300 A/μs | Q2 | | 54 | | nC |

Notes:

1.R_{0,A} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0CA} is determined by the user's board design.





b. 125 °C/W when mounted on a minimum pad of 2 oz copper

a. 57 °C/W when mounted on a 1 in² pad of 2 oz copper



- 10-

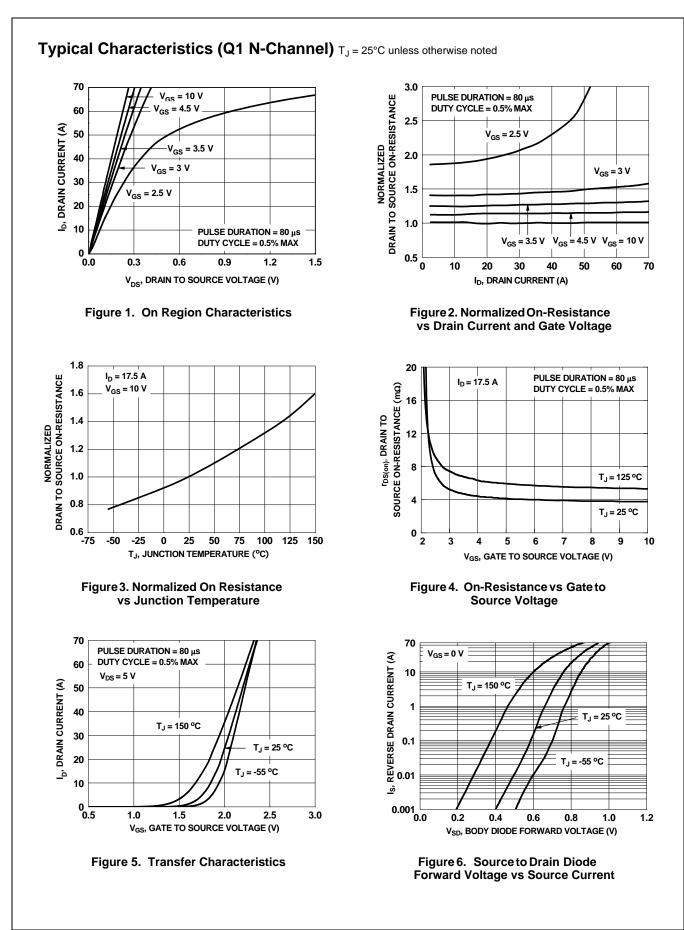
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c. 50 °C/W when mounted on a 1 in² pad of 2 oz copper

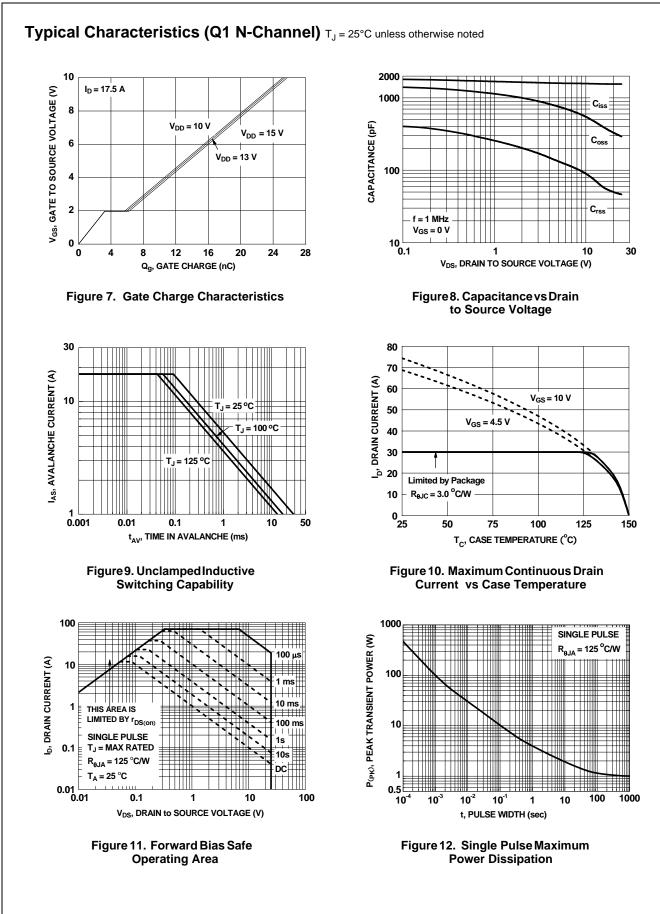
 d. 120 °C/W when mounted on a minimum pad of 2 oz copper

2 Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

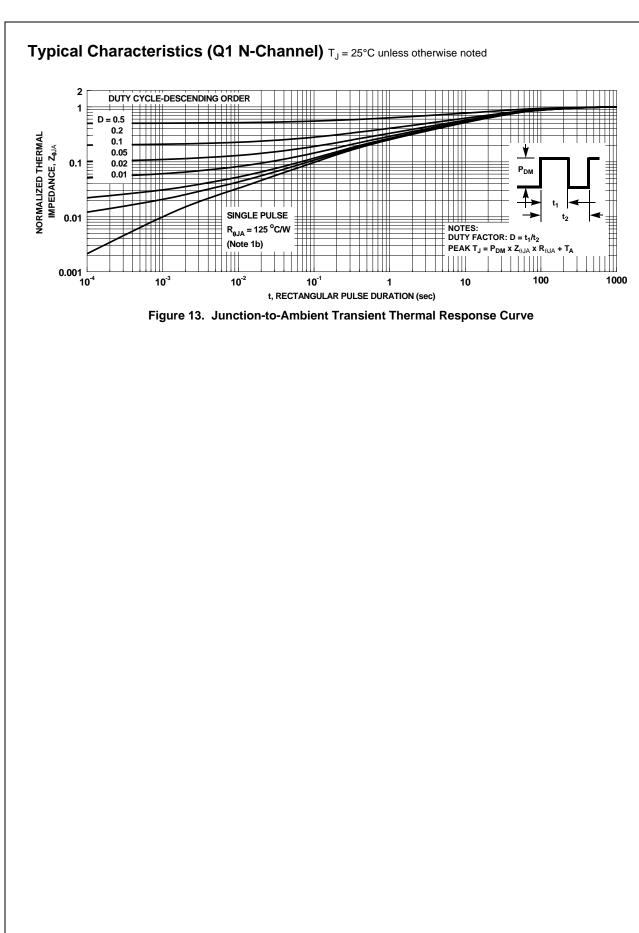
3. Q1 :E_{AS} of 29 mJ is based on starting T_J = 25 °C; N-ch: L = 0.3 mH, I_{AS} = 14 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L= 0.1 mH, I_{AS} = 20 A. Q2: E_{AS} of 135 mJ is based on starting T_J = 25 °C; N-ch: L = 0.3 mH, I_{AS} = 30 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L= 0.1 mH, I_{AS} = 44 A. 4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

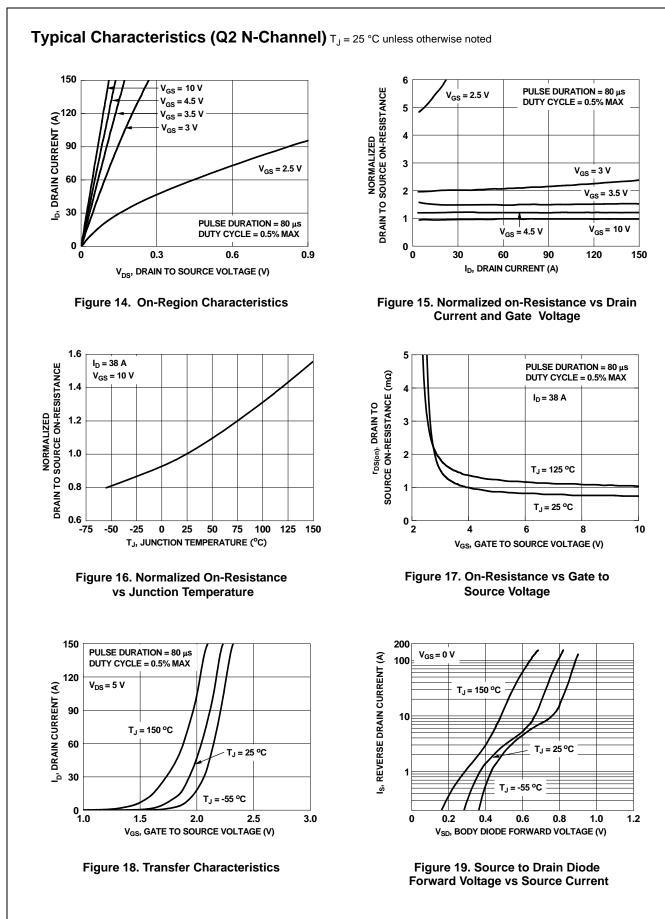


FDMS3620S PowerTrench[®] PowerStage

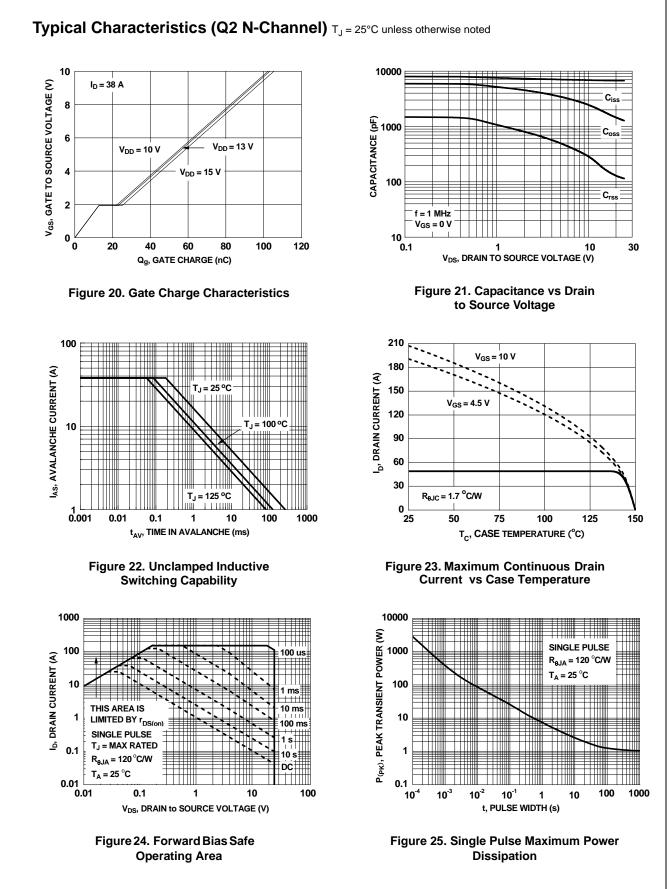




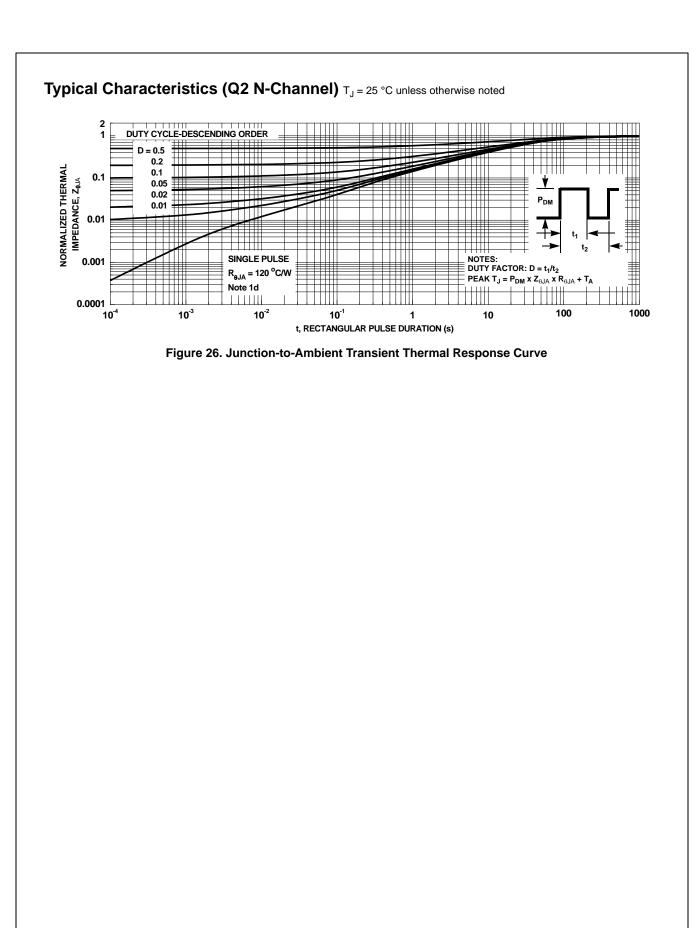








FDMS3620S PowerTrench[®] PowerStage



Typical Characteristics (Q2 N-Channel)

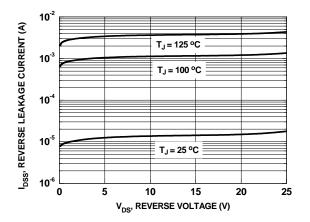
SyncFET Schottky body diode Characteristics

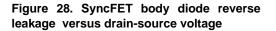
Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDMS3620S.

45 40 35 30 di/dt = 300 A/µs 10 5 0 -5 50 100 150 200 300 0 250 350 TIME (ns)

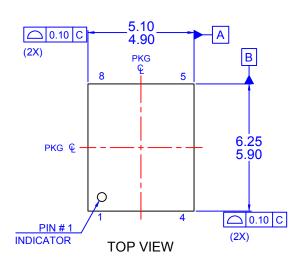
Figure 27. FDMS3620S SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.



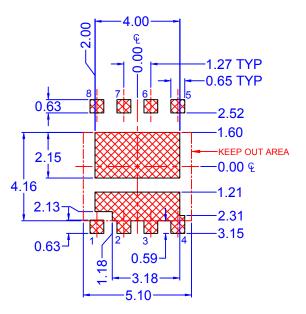


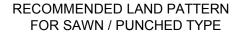
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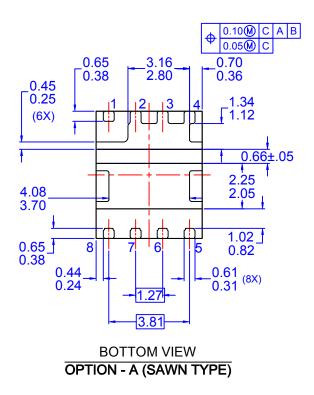


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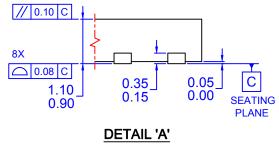
DETAIL A



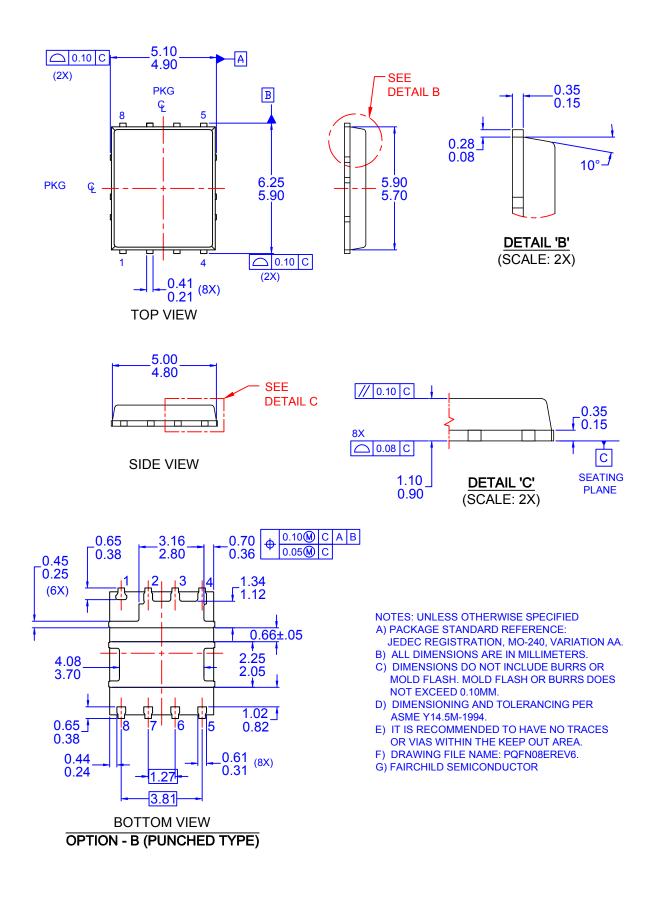




SIDE VIEW



(SCALE: 2X)



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